Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/612,457	MORGAN, FABIAN F.	
Examiner	Art Unit	
Isaac T. Tecklu	2192	

	SEARCHED					
Class	Subclass	Date	Examiner			
717	114, 116	5/15/2007	ΙΤ			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Searched EAST all database	5/15/2007	ΙΤ		